Search Notes

Applicat	tion/Contro	l No.

Applicant(s)/Patent under Reexamination
CHEN ET AL.

10/807,714

Art Unit

Examiner

2826

Tuan Quach

	SEARCHED				
Class	Subclass	Date	Examiner		
257	78, 200, 442, 614	3/25/2007	TQ		
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST (USPAT; USPGPUG; EPO; JPO; DERWENT;IBMTDB) - see search history printout	3/25/2007	TQ	
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